

Notice of References Cited		Application/Control No. 10/666,371	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner ALAN LUONG	Art Unit 2623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0126600 A1	07-2003	Heuvelman, Jeroen	725/35
*	B	US-7,055,167 B1	05-2006	Masters, Bradley S.	725/39
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 0040021 A1	07-2000	WIPO	Montie et al.	H04N5/782
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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